HAT2053M

Silicon N Channel Power MOS FET Power Switching

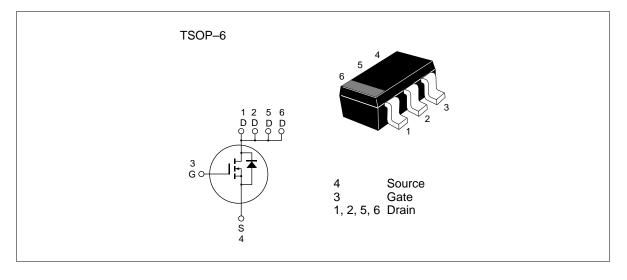
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ADE-208-755B(Z) Preliminary 3rd. Edition December 1998

Features

- Low on-resistance
- Low drive current
- · High density mounting
- 2.5V gate drive device can be driven from 3V source

Outline





HAT2053M

Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings	Unit
Drain to source voltage	$V_{\scriptscriptstyle DSS}$	20	V
Gate to source voltage	V_{GSS}	±12	V
Drain current	_D *2	6.1	A
Drain peak current	l *1 D(pulse)	24.4	A
Body-drain diode reverse drain current	_{DR} *2	6.1	A
Channel dissipation	Pch _(pulse) *2	2.0	W
	Pch _(continuous) *3	1.05	W
Channel temperature	Tch	150	°C
Storage temperature	Tstg	-55 to +150	°C

Notes: 1. PW \leq 10 μ s, duty cycle \leq 1 %

- 2. When using the alumina ceramic board (50 x 50 x 0.7 mm), PW≤ 5s,Ta=25°C
- 3. When using the alumina ceramic board (50 x 50 x 0.7 mm) ,Ta=25°C

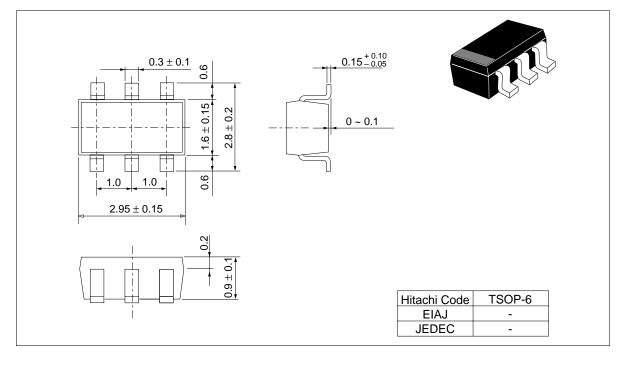
Electrical Characteristics (Ta = 25°C)

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	20	_	_	V	$I_{D} = 10 \text{mA}, V_{GS} = 0$
Gate to source leak current	I _{GSS}	_	_	±0.1	μΑ	$V_{GS} = \pm 12V, V_{DS} = 0$
Zero gate voltege drain current	I _{DSS}	_	_	1	μΑ	$V_{DS} = 20 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	$V_{\text{GS(off)}}$	0.4	_	1.4	V	$V_{DS} = 10V$, $I_{D} = 1mA$
Static drain to source on state	$R_{\scriptscriptstyle DS(on)}$	_	28	33	$m\Omega$	$I_D = 3A$, $V_{GS} = 4.5V^{*1}$
resistance	$R_{\scriptscriptstyle DS(on)}$	_	37	48	$m\Omega$	$I_D = 3A, V_{GS} = 2.5V^{*1}$
Forward transfer admittance	y _{fs}	6.5	11	_	S	$I_D = 3A, V_{DS} = 10V^{*1}$
Input capacitance	Ciss	_	570	_	pF	V _{DS} = 10V
Output capacitance	Coss	_	220	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	160	_	pF	f = 1MHz
Turn-on delay time	$t_{\text{d(on)}}$	_	15	_	ns	$V_{GS} = 4.5V, I_{D} = 3A$
Rise time	t _r	_	100	_	ns	$R_L = 3.3\Omega$
Turn-off delay time	t _{d(off)}	_	90	_	ns	_
Fall time	t _f	_	105	_	ns	_
Body-drain diode forward voltage	V_{DF}	_	0.95	_	V	IF = 6.1A, V _{GS} = 0 *1
Body–drain diode reverse recovery time	t _{rr}	_	(50)	_	ns	$IF = 6.1A, V_{GS} = 0$ $diF/ dt = 20A/\mu s$

Note: 1. Pulse test

Package Dimensions

Unit: mm



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